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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/789,352	02/26/2004	Yoko Sato	60538 (48229)	9123
21874	7590	01/24/2006	EXAMINER	
EDWARDS & ANGELL, LLP P.O. BOX 55874 BOSTON, MA 02205				RICHARDS, N DREW
			ART UNIT	PAPER NUMBER
			2815	

DATE MAILED: 01/24/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary	Application No.	Applicant(s)	
	10/789,352	SATO, YOKO	
	Examiner	Art Unit	
	N. Drew Richards	2815	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) Responsive to communication(s) filed on 04 November 2005.
 2a) This action is FINAL. 2b) This action is non-final.
 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) Claim(s) 1-25 is/are pending in the application.
 4a) Of the above claim(s) 11-19 and 22-25 is/are withdrawn from consideration.
 5) Claim(s) _____ is/are allowed.
 6) Claim(s) 1-10, 20 and 21 is/are rejected.
 7) Claim(s) _____ is/are objected to.
 8) Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) The specification is objected to by the Examiner.
 10) The drawing(s) filed on 26 February 2004 is/are: a) accepted or b) objected to by the Examiner.
 Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
 Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
 a) All b) Some * c) None of:
 1. Certified copies of the priority documents have been received.
 2. Certified copies of the priority documents have been received in Application No. _____.
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|---|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413) |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | Paper No(s)/Mail Date. _____ . |
| 3) <input checked="" type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date <u>2/26/04, 7/18/05</u> . | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| | 6) <input type="checkbox"/> Other: _____ . |

DETAILED ACTION

Election/Restrictions

1. Applicant's election without traverse of device claims 1-10 in the reply filed on 11/4/05 is acknowledged. Since claims 20 and 21 are linking claims, claims 1-10, 20 and 21 are examined herein.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

3. Claims 1-4, 7, 8, 20 and 21 are rejected under 35 U.S.C. 102(b) as being anticipated by JP-2001-351995 (cited by applicant).

With regard to claim 1, JP-2001-351995 discloses in figure 36, for example, a semiconductor device comprising:

- a support substrate 2;
- an insulating layer 3 formed on the support substrate;
- a first semiconductor layer 4 (left third of the figure) formed on the insulating layer;
- a first high breakdown voltage transistor formed in the first semiconductor layer;
- a second semiconductor layer 4 (right third of the figure) formed on the insulating layer;

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- a second high breakdown voltage transistor formed in the second semiconductor layer;
- a first isolation region 45/47 formed between the first semiconductor layer and the second semiconductor layer, the first isolation region having a depth that reaches the insulating layer;
- a third semiconductor layer 4 (middle third of the figure) formed on the insulating layer;
- a first low breakdown voltage transistor formed in the third semiconductor layer;
- a second low breakdown voltage transistor formed in the third semiconductor layer; and
- a second isolation region 5 formed in the third semiconductor layer between the first low breakdown voltage transistor and the second low breakdown voltage transistor, the second isolation region having a depth that does not reach the insulating layer.

With regard to claim 2, JP-2001-351995 further discloses a third isolation region 45/47 formed between the second semiconductor layer and the third semiconductor layer, the third isolation region having a depth that reaches the insulating layer.

With regard to claims 3 and 4, the first, second and third semiconductor layer are all of equal thickness.

With regard to claims 7 and 8, the surfaces of the first, second and third semiconductor layers are at a same level.

With regard to claim 20, this claim is merely broader in scope than claim 1 and thus JP-2001-351995 discloses all the limitations therein.

With regard to claim 21, since JP-2001-351995 discloses the device they also disclose the claimed method of manufacturing the device.

Claim Rejections - 35 USC § 103

4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

5. Claims 5 and 6 are rejected under 35 U.S.C. 103(a) as being unpatentable over JP-2001-351995.

JP-2001-351995 teaches the first, second and third semiconductor layers having the same thickness but is silent as to the thickness being 500 to 2000 nm. However, Official Notice is taken that it was well known to the skilled artisan at the time of the invention to form the semiconductor layers (SOI layers) to the claimed thickness. It is known to form the semiconductor layers to an large enough thickness to allow for proper device operation while keeping the layer thin to save on material and processing costs. These claims are *prima facie* obvious without showing that the claimed ranges achieve unexpected results relative to the prior art range. In re Woodruff, 16 USPQ2d 1935, 1937 (Fed. Cir. 1990). See also In re Huang, 40 USPQ2d 1685, 1688(Fed. Cir. 1996)(claimed ranges of a result effective variable, which do not overlap the prior art

ranges, are unpatentable unless they produce a new and unexpected result which is different in kind and not merely in degree from the results of the prior art). See also *In re Boesch*, 205 USPQ 215 (CCPA) (discovery of optimum value of result effective variable in known process is ordinarily within skill of art) and *In re Aller*, 105 USPQ 233 (CCPA 1955) (selection of optimum ranges within prior art general conditions is obvious).

6. Claims 9 and 10 are rejected under 35 U.S.C. 103(a) as being unpatentable over JP-2001-351995 as applied to claims 1-4, 7, 8, 20 and 21 above, and further in view of Kojima (US 5,965,921).

JP-2001-351995 teaches the first and second high breakdown voltage transistors comprising a first gate insulating layer 6 formed above a channel region, but does not teach a second gate insulating layer formed above an offset region and thicker than the first gate insulating layer.

Kojima teach high voltage MOSFET's in figure 1. Kojima teach a first gate insulating layer 3E formed above a channel region and a second gate insulating layer (unlabeled, thick insulator above 3C) above an offset region 3C wherein the second gate insulating layer is thicker than the first gate insulating layer.

JP-2001-351995 and Kojima are combinable because they are from the same field of endeavor. At the time of the invention it would have been obvious to one of ordinary skill in the art to form the first and second high breakdown voltage transistors of JP-2001-351995 with the first and second gate insulating layers as taught by Kojima.

The motivation for doing so is to improve the short channel effect or to reduce the gate drain capacitance and gate-drain breakdown. Therefore, it would have been obvious to combine JP-2001-351995 with Kojima to obtain the invention of claims 9 and 10.

Conclusion

7. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Arai (US 5,841,174), Matsumoto et al. (US 6,933,565 B2).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to N. Drew Richards whose telephone number is (571) 272-1736. The examiner can normally be reached on Monday-Friday 9:00-5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Ken Parker can be reached on (571) 272-2298. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).



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